
**Microbeam analysis — Electron
probe microanalysis — Quantitative
point analysis for bulk specimens
using wavelength dispersive X-ray
spectroscopy**

*Analyse par microfaisceaux — Microsonde de Castaing — Analyse
quantitative ponctuelle d'échantillons massifs par spectrométrie à
dispersion de longueur d'onde*



COPYRIGHT PROTECTED DOCUMENT

© ISO 2016, Published in Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized otherwise in any form or by any means, electronic or mechanical, including photocopying, or posting on the internet or an intranet, without prior written permission. Permission can be requested from either ISO at the address below or ISO's member body in the country of the requester.

ISO copyright office
Ch. de Blandonnet 8 • CP 401
CH-1214 Vernier, Geneva, Switzerland
Tel. +41 22 749 01 11
Fax +41 22 749 09 47
copyright@iso.org
www.iso.org